

# Traceable Radiometric Calibration in the EUV/VUV Spectral Range using Synchrotron Radiation

Alexander Gottwald

Michael Kolbe, Christian Laubis

Roman Klein, Reiner Thornagel

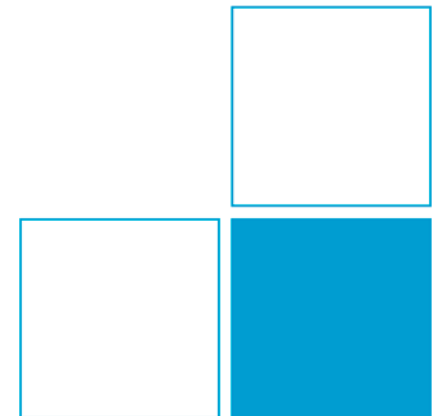
Frank Scholze

UV and VUV Radiometry

EUV Radiometry

Synchrotron Radiation Sources

Radiometry with Synchrotron Radiation (dept.)



# Subtitle?

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**What you should expect from state-of-the-art ground based radiometric calibrations  
in the wavelength range **from 5 nm to 200 nm****

# Outline

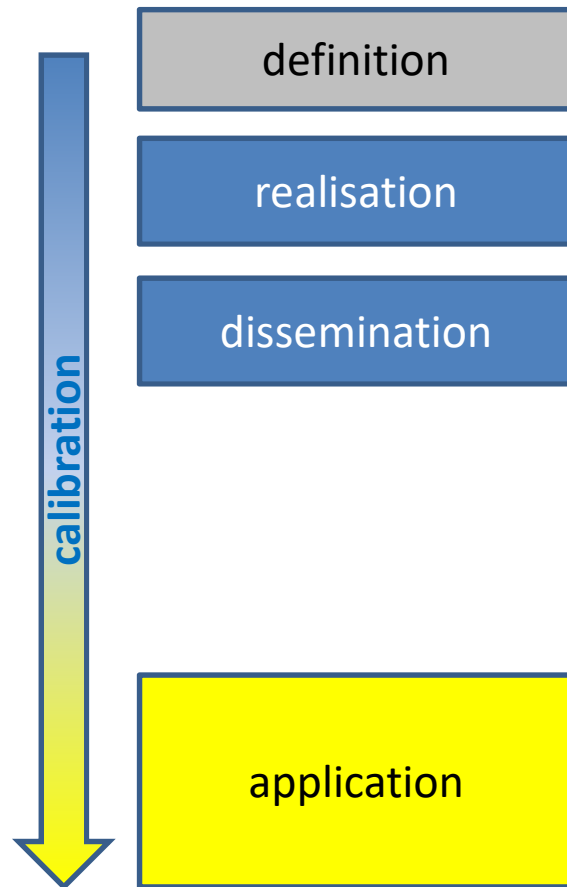
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- **The basic principles: Traceability in Radiometry**
- **How to use Synchrotron Radiation**
- **How to make a precision measurement**
- **Limits**
- **Examples**

# Traceability

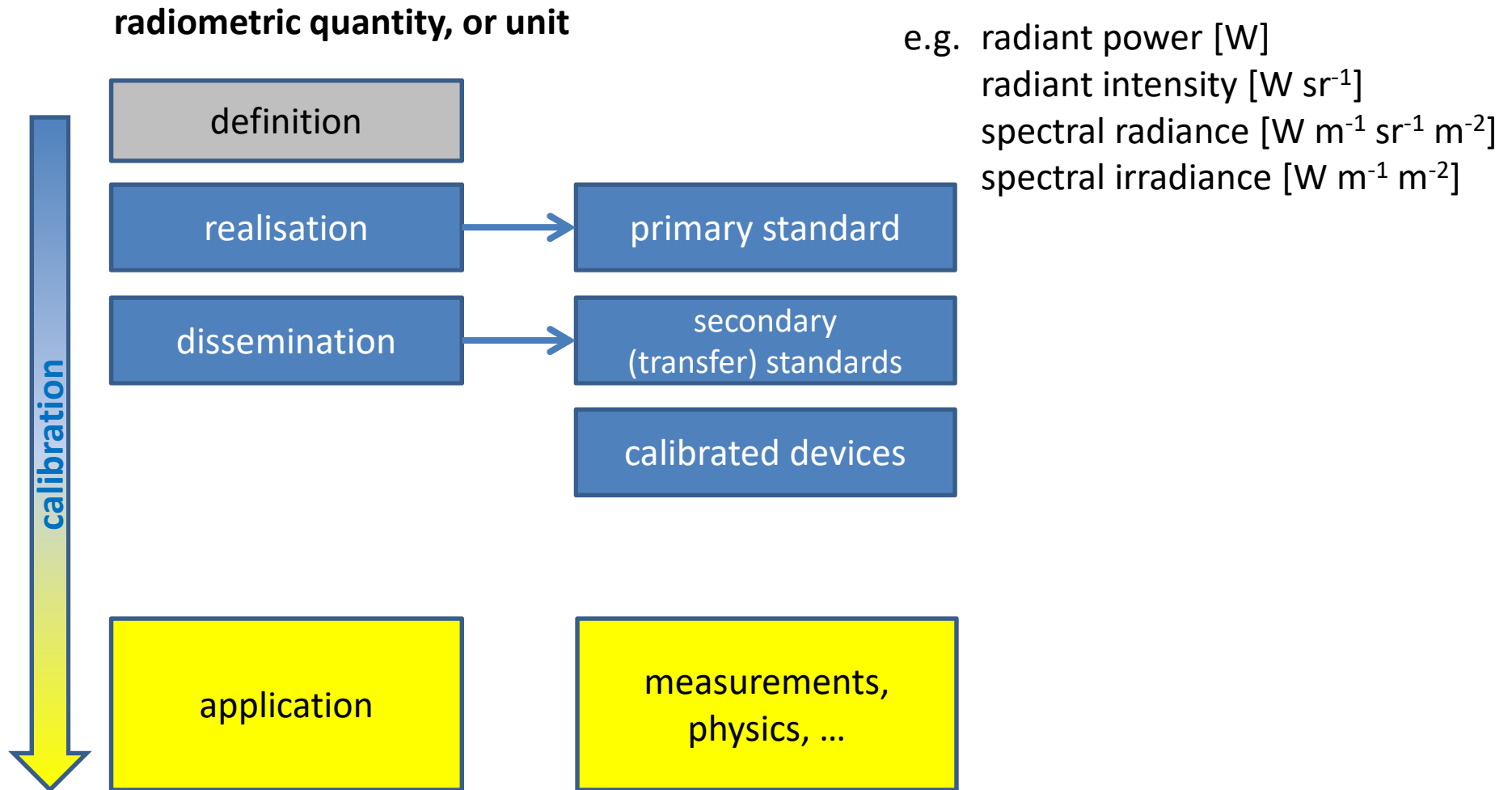
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radiometric quantity, or unit

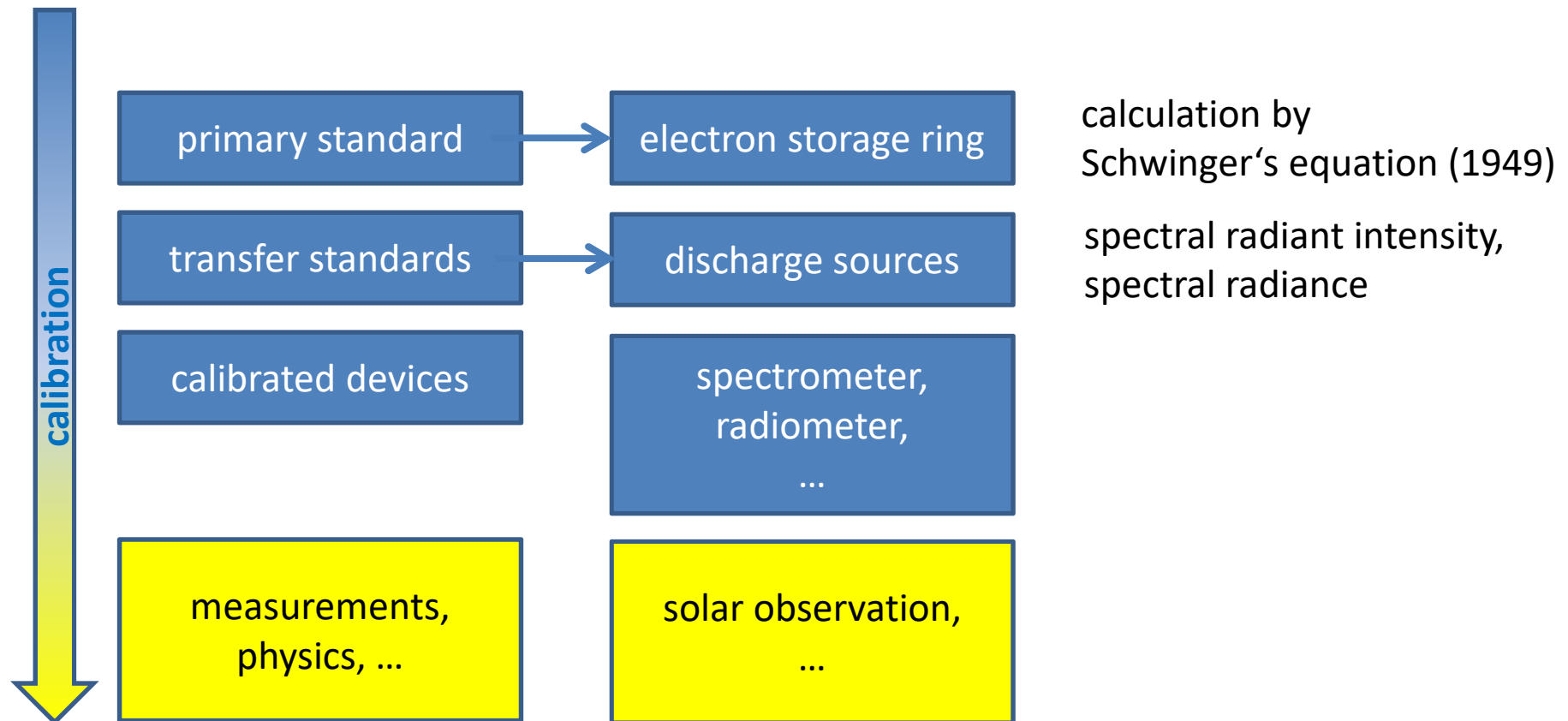


e.g. radiant power [W]  
radiant intensity [W sr<sup>-1</sup>]  
spectral radiance [W m<sup>-1</sup> sr<sup>-1</sup> m<sup>-2</sup>]  
spectral irradiance [W m<sup>-1</sup> m<sup>-2</sup>]

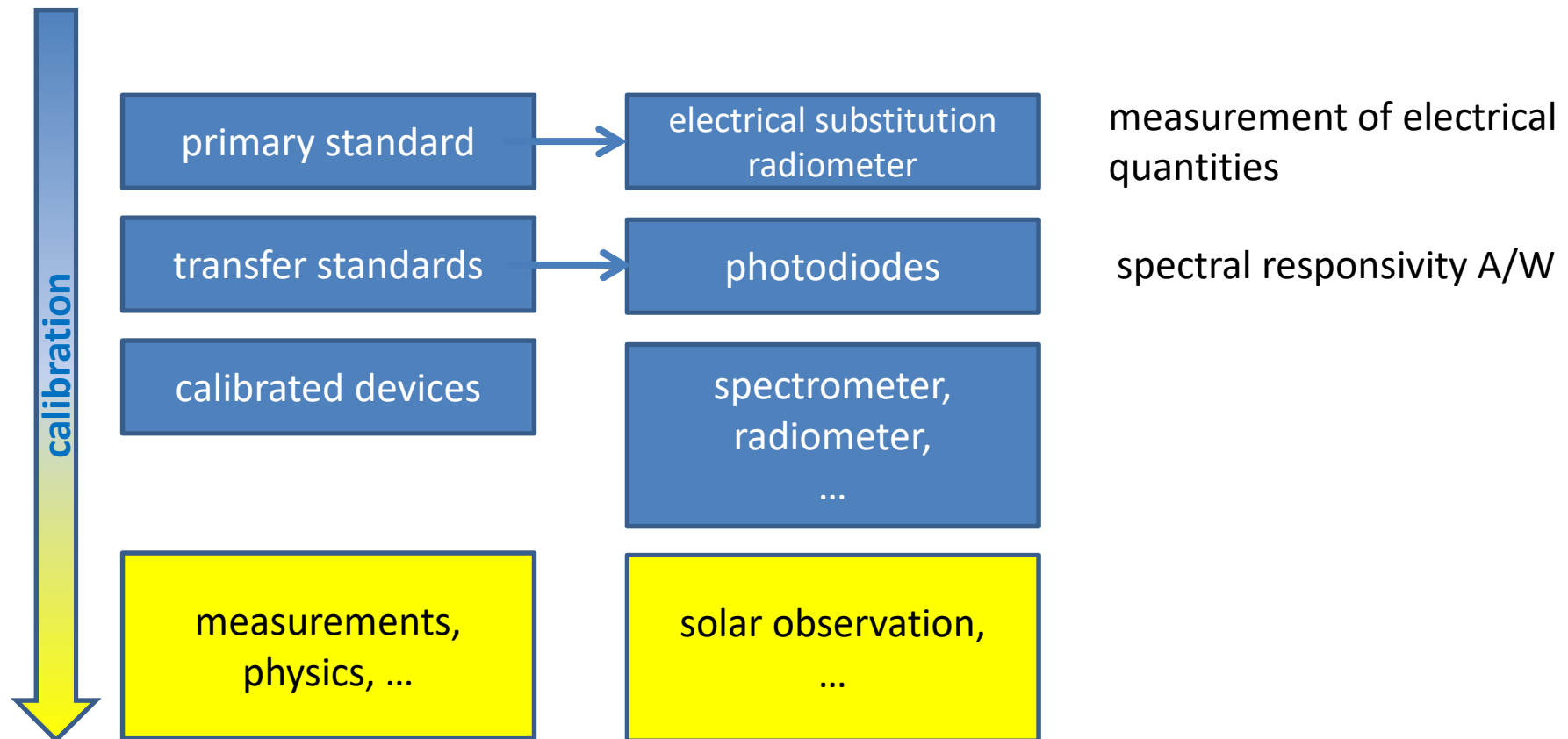
# Traceability



# Source based radiometry

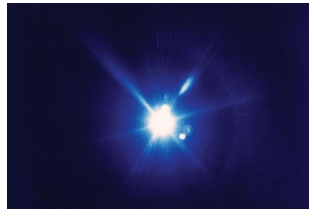


# Detector based radiometry



# Why synchrotron radiation ?

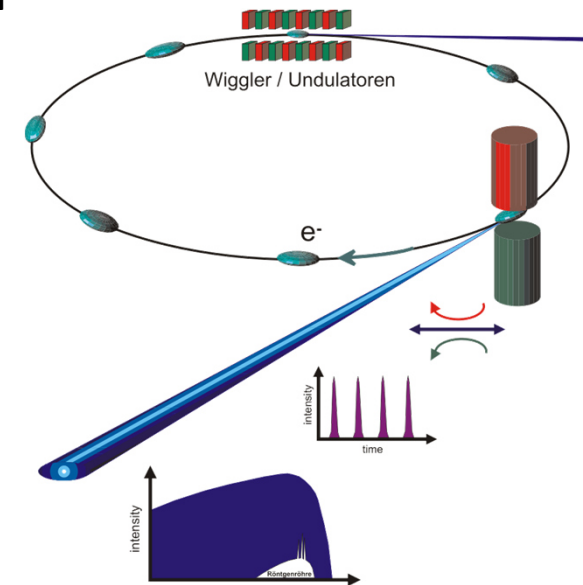
Synchrotron radiation is emitted when charged particles with relativistic energies are accelerated in a magnetic field



typical source:

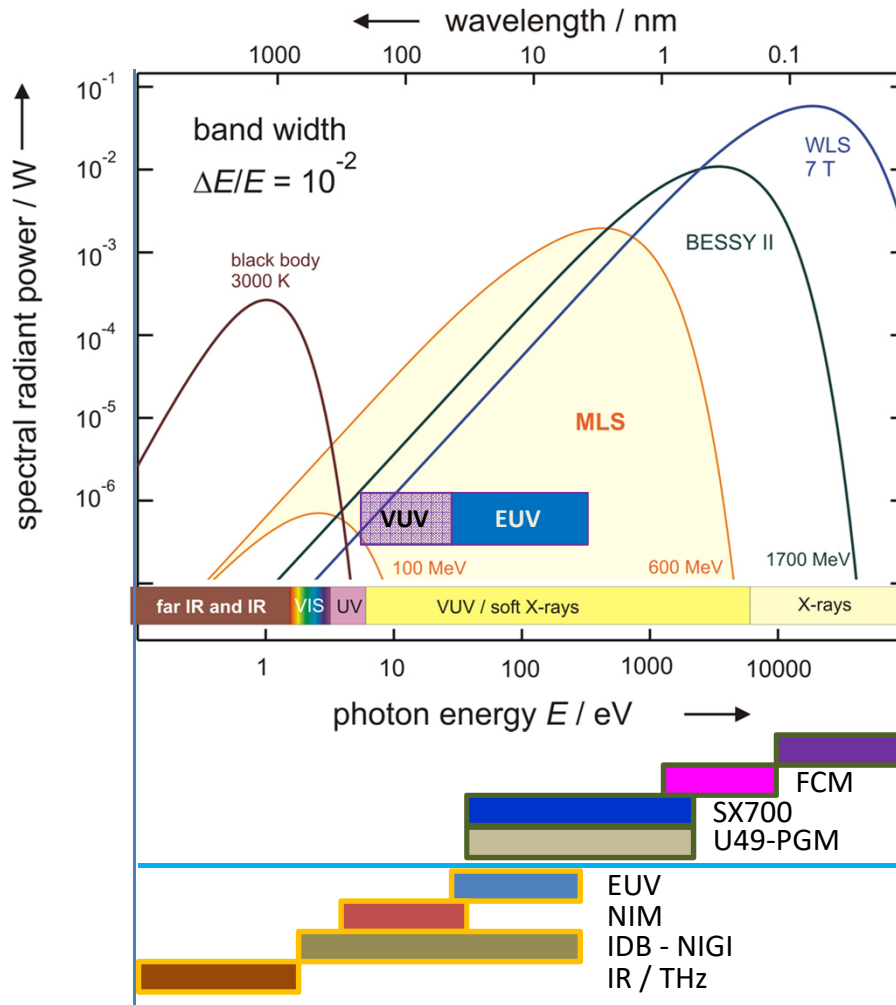
electron storage rings = (few) GeV particle accelerators

- bright  $> 10^{11}$  photons/s/0.1%BW
- brilliant  $> 10^{20}$  photons/s/mm<sup>2</sup>/mrad<sup>2</sup>/0.1%BW  
thus: directional emission
- „white“ = broadband from IR to X-ray  
thus: **tunable with monochromators**  
also **in the EUV and VUV range**
- „clean“ = UHV conditions, no debris
- emission is **calculable** from basic physical equations (Schwinger 1949):  
Thus **an electron storage ring can be operated as primary source standard.**

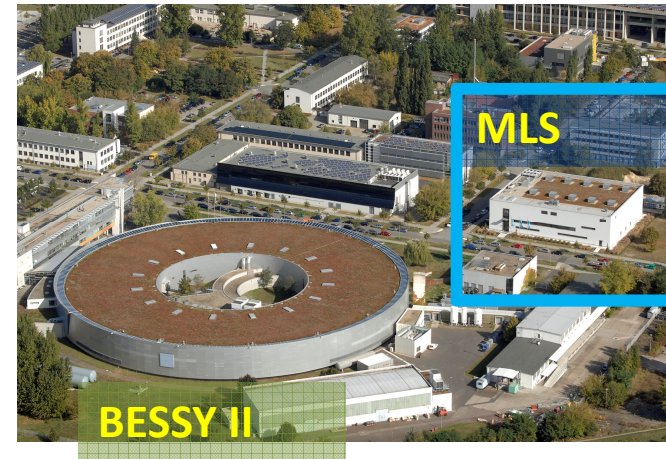




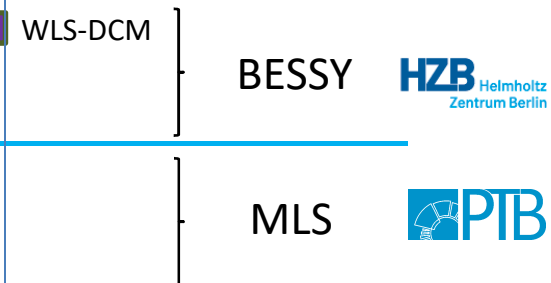
# Synchrotron radiation available at PTB



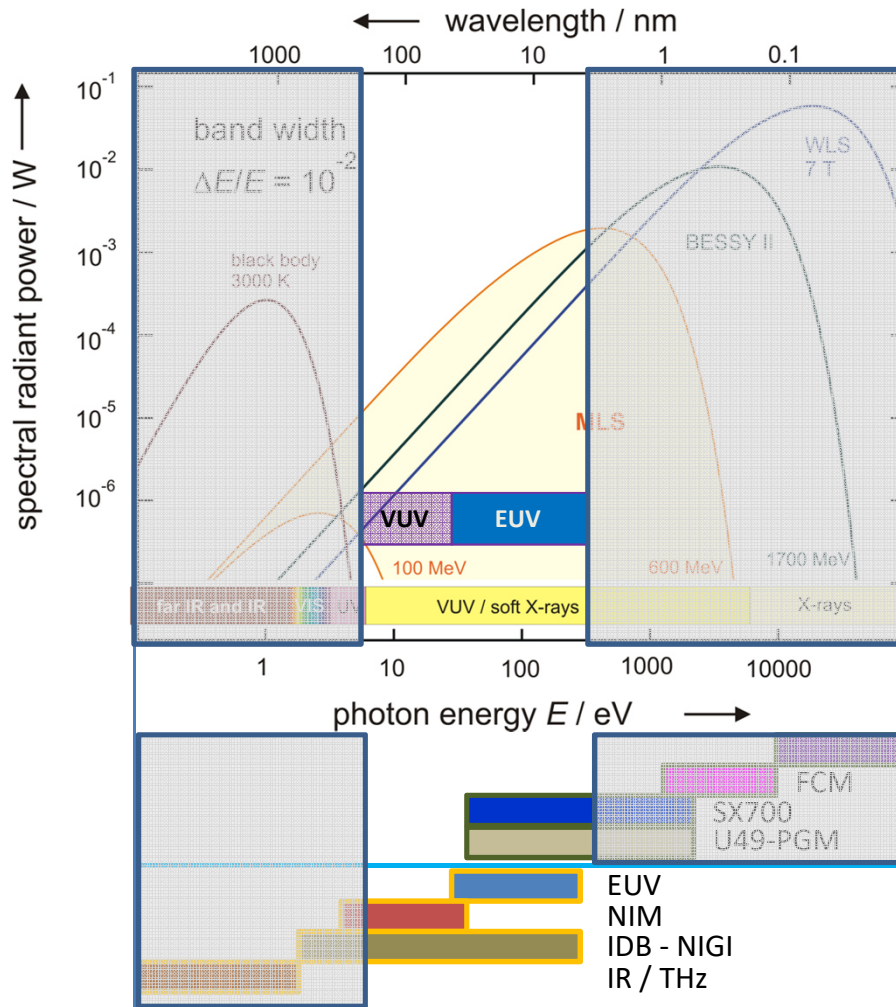
## Berlin-Adlershof



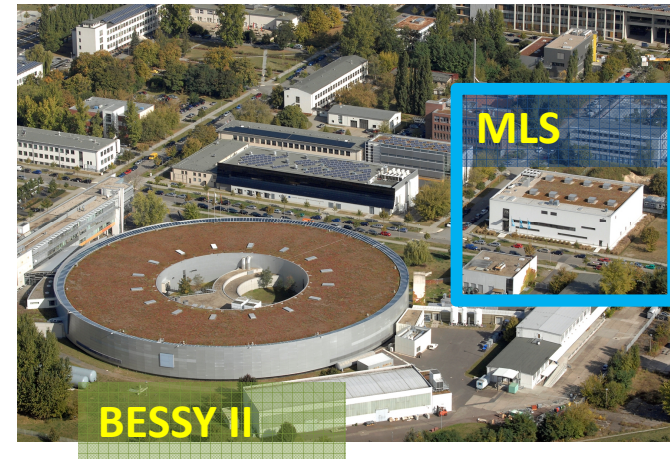
## PTB monochromator beamlines:



# Synchrotron radiation available at PTB



## Berlin-Adlershof



## PTB monochromator beamlines:

BESSY  Helmholtz Zentrum Berlin

MLS 

# Main relative uncertainty contributions ( $k=1$ , in %)

## source based calibration

Radiant intensity, D<sub>2</sub> Lamp 200 nm

<b>electron beam current, <math>I</math></b>	<b>0.5</b>
electron energy, $W$	0.012
mag. Induction, $B$	0.0005
eff. vertical source size, $\Sigma_y$	0.07
offset to orbit plane, $\psi$	0.01
<b>total [storage ring]</b>	<b>0.51</b>

non-linearity of detector	0.3
<b>stability within SR calibrations</b>	<b>2.2</b>
distance difference to AP	0.21
<b>higher diffraction orders</b>	<b>0.5</b>
<b>stray light</b>	<b>0.5</b>
<b>total [transfer monochromator]</b>	<b>2.4</b>

<b>D2 source stability</b>	<b>2.0</b>
source alignment	0.5
wavelength calibration	0.1
residual polarization of source	0.5
<b>total [D2 Lamp]</b>	<b>2.1</b>

<b>total</b>	<b>3.2</b>
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realisation

dissemination

calibration

## detector based calibration

Spectral responsivity, Si photodiode, 13 nm

<b>normalized heating power difference</b>	<b>0.1</b>
radiant conversion efficiency	0.03
thermal non-equivalence	0.012
electr. calibration	0.002
<b>total [electr. subst. radiometer]</b>	<b>0.11</b>

measured diode photocurrent	0.1
electrometer calibration	0.06
wavelength uncertainty	0.01
spectral bandwidth	0.005
higher diffraction orders	0.03
<b>diffuse scattered light</b>	<b>0.2</b>
angle of incidence	0.005
<b>total [beamline]</b>	<b>0.23</b>

<b>detector non-uniform responsivity</b>	<b>0.2</b>
non-linearity	0.12
temperature dependence	0.05
polarisation	0.10
<b>total [detector]</b>	<b>0.26</b>

<b>total</b>	<b>0.37</b>
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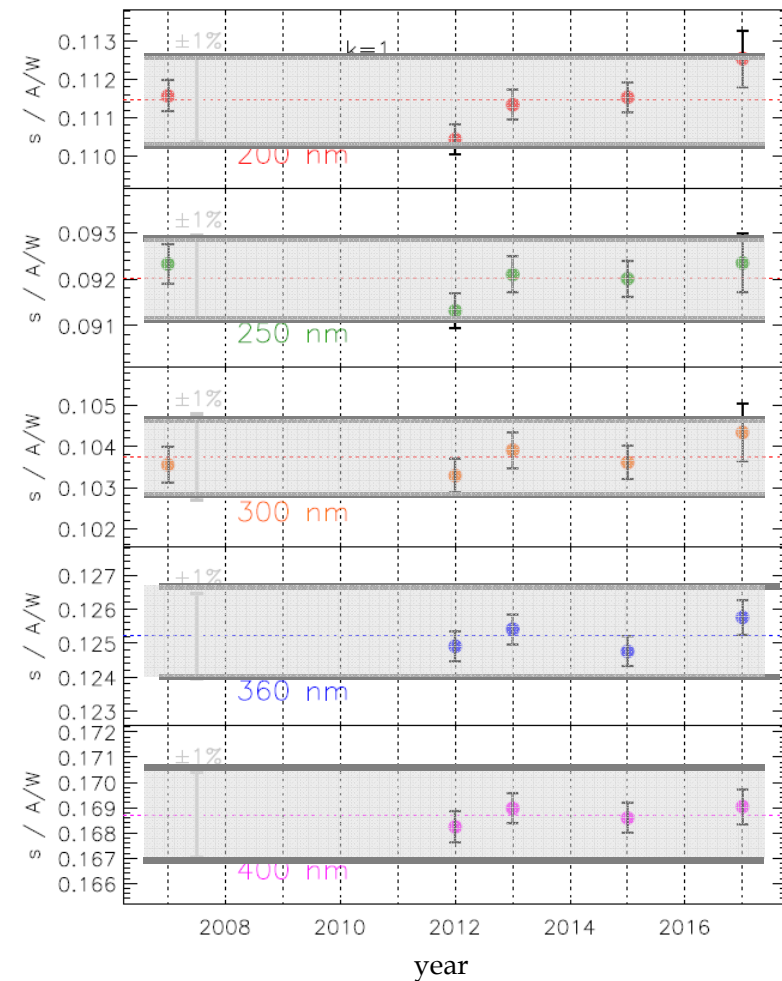
# Internal Validation

## Reproducibility of calibrations: calibration history

- set of own secondary standard detectors as reference (~ 6 individuals, different types)
- regularly re-calibrated

- **individual drifts in responsivity**
  - < 1 % / 5 years for  $\lambda > 150$  nm
  - < 5 % / 5 years for  $40\text{nm} < \lambda < 150$  nm
  - < 1 % / 5 years for  $\lambda < 40$  nm
- **systematic changes: not observed**

AXUV100G 06-12 #5

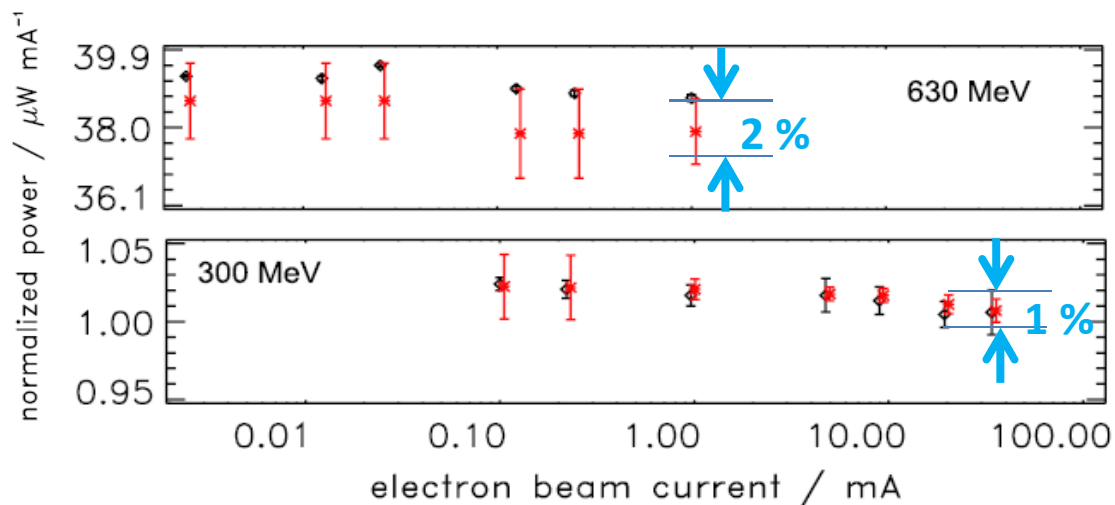


# Internal Validation

How it is assured that different realisations of an unit are equivalent ?

- **Direct** comparison of the primary standards

R. Klein, A. Gottwald, et al., *Radiometric comparison of the primary source standard 'Metrology Light Source' to a primary detector standard*, Metrologia **48**, 219 (2011)



**red: source (calc.)**

**blk: detector**

standard uncertainties  
( $k = 1$ )

**overall agreement ~ 1 %**

integral comparison,  
i.e. not spectrally dispersed !

# External Validation

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## How to assure that realisations of an unit at different NMIs are equivalent ?

formal : Mutual Recognition Agreement (MRA) through the  
International Committee for Weights and Measures (CIPM)

“National Metrology Institutes demonstrate the international equivalence of their measurement standards and the calibration and measurement certificates they issue.”

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- **Source based radiometry**

U. Arp, R. Klein, Z. Li, W. Paustian, M. Richter, P.-S. Shaw, and R. Thornagel:

*Synchrotron radiation-based bilateral **intercomparison** of **ultraviolet** source calibrations,*

*Metrologia* **48**, 261 (2011)

range: 200 nm – 350 nm

NIST - PTB

overall agreement < 5 %

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Metrologia **48**, 261 (2011)

range: 200 nm – 350 nm NIST - PTB overall agreement < 5 %

### ■ Detector based radiometry

F. Scholze, R. Vest and T. Saito: *Report on the CCPR Pilot **Comparison**: Spectral Responsivity **10 nm to 20 nm**,*  
Metrologia **47**, 02001 (2010)

NIST - NMIJ - PTB overall agreement ~ 1-2 %

A. Gottwald, M. Richter, P.-S. Shaw, Z. Li, and U. Arp: *Bilateral NIST–PTB **comparison** of spectral responsivity in the **VUV**,* Metrologia **48**, 02001 (2011)

range 135 nm – 250 nm NIST - PTB overall agreement ~ 1-4 %



# Limits in disseminating radiometric scales

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## transfer source standards

	stability
>200 nm :	
D2 lamp, FEL lamp	~ 1 %
>120 nm :	
D2 lamp MgF <sub>2</sub> Window	> 1 %
< 120 nm	
HC (line spectrum)	>> 5 %

## transfer detector standards

(photodiodes)

stability, uniformity depending on:

- type
- wavelength
- irradiation
- storage

e.g.

Si PD with thin oxide (e.g. AXUV, S10043)

Si with metallic layer (e.g. SXUV)

B-doped Si (e.g. SPD-100UV)

Schottky (SUV100)

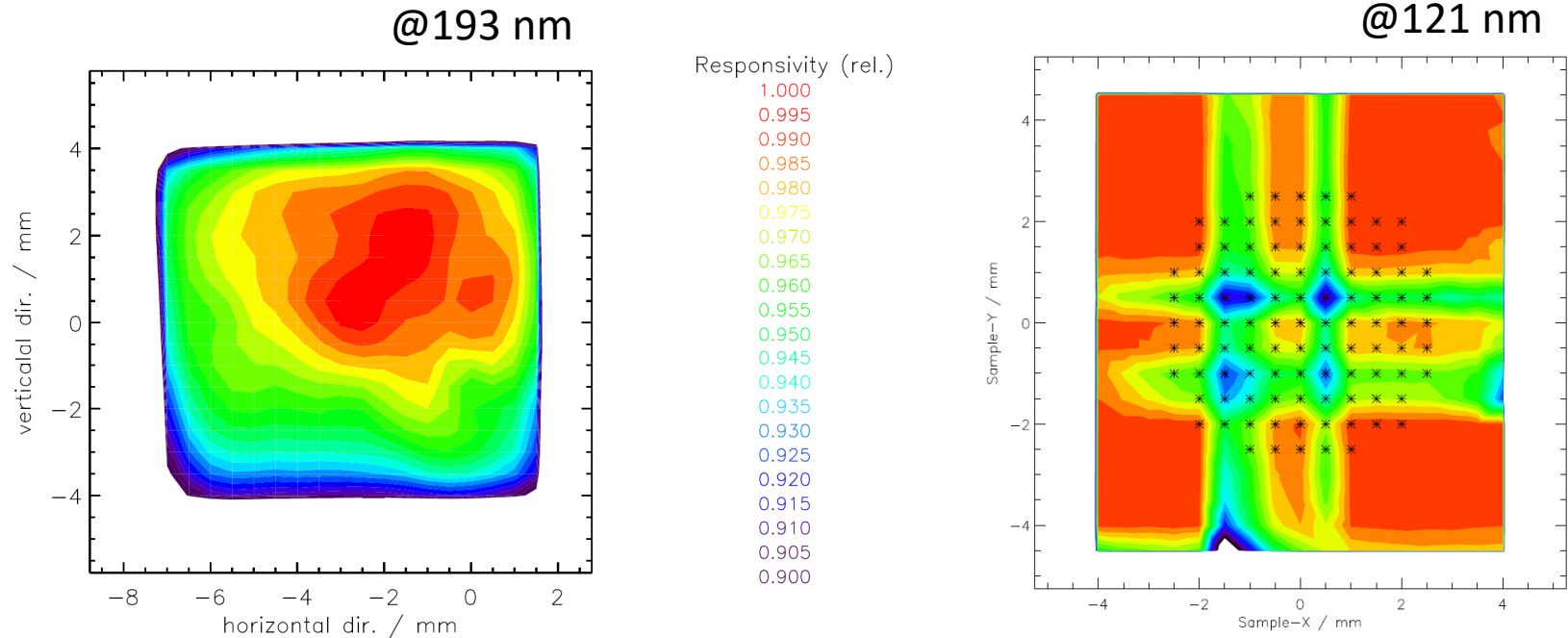
**stability issues** due to:

- irradiation aging
- contamination

**most critical range: 50 nm to 170 nm**

# Specific photodiode problems

initial non-uniformity (wafer processing)



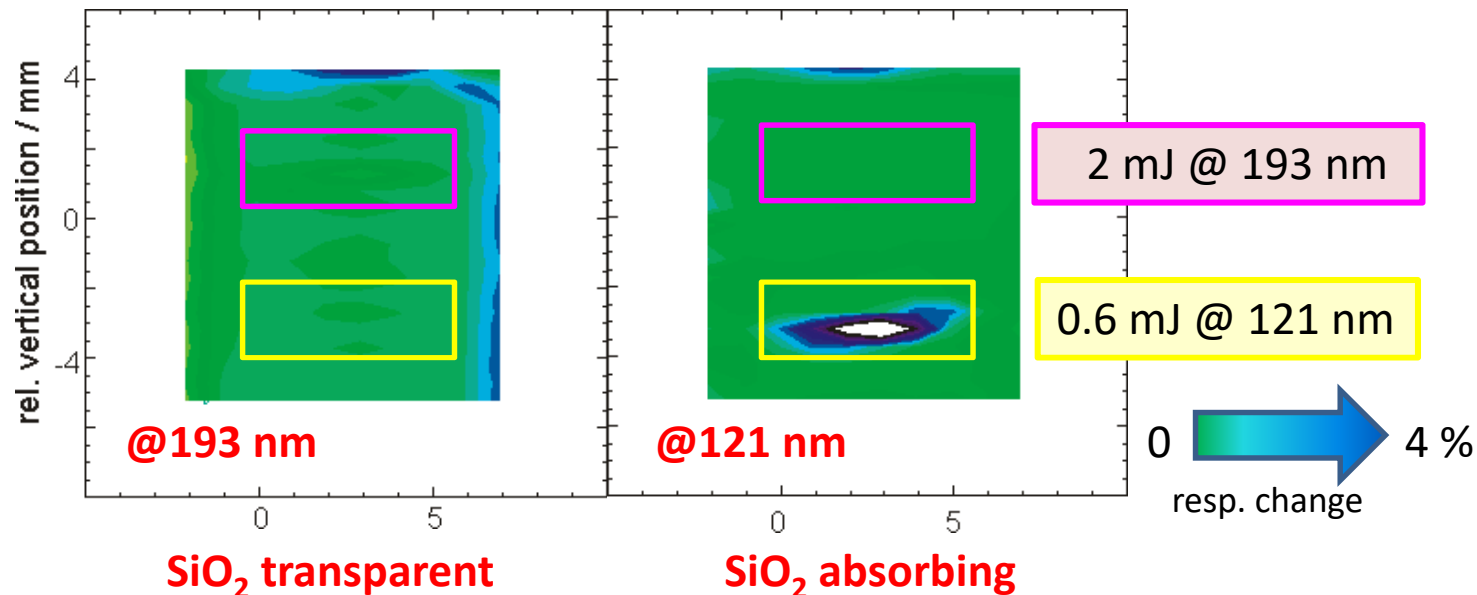
Bor-doped Si PD (SPD100-UV):  
Doping profile (ion implant + diffusion)

Si PD (AXUV100G):  
recent series (> ~ 2016):  
line structures in thin oxide layer  
(> 10 % 70 nm)

# Example for ageing: Si photodiode

AXUV-100G photodiode 10 mm x 10 mm

Relative spectral responsivity map:

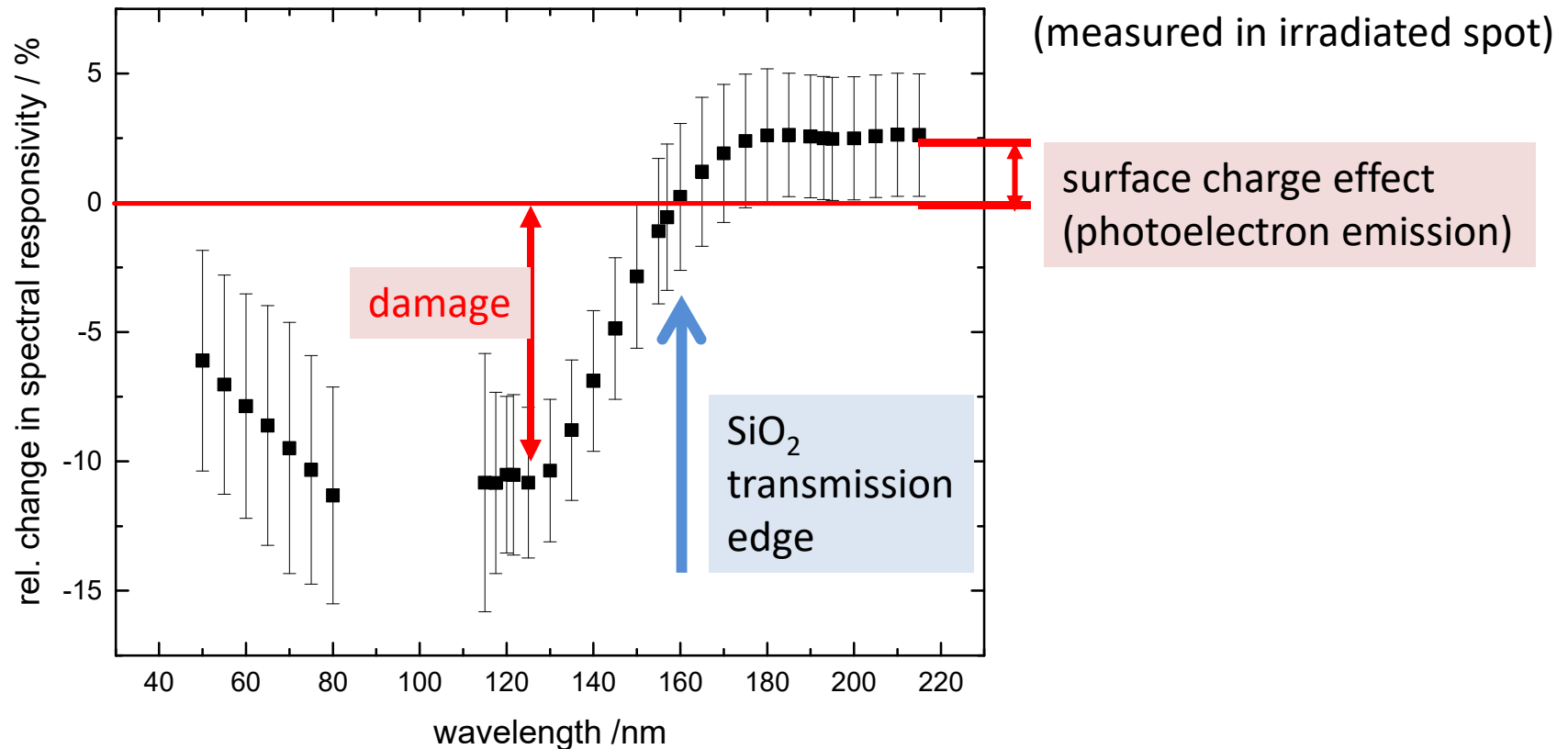


- weak effect of 193 nm irradiation.
- **massive effect of 121 nm irradiation**
- **irreversible damage of the SiO<sub>2</sub> passivation layer cannot be removed by surface cleaning**

# Example for ageing: Si photodiode

AXUV-100G photodiode 10 mm x 10 mm

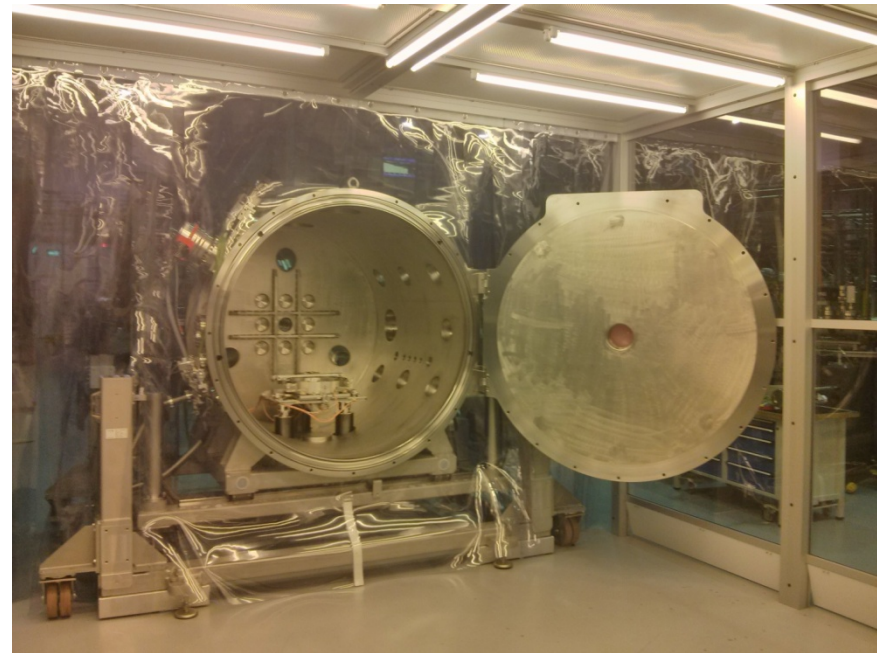
change of spectral responsivity with wavelength **after 121 nm irradiation**



# Calibration of spectrometers

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- located at PTB's Metrology Light Source (MLS) in Berlin-Adlershof
- clean room ISO class 5 specification
- UHV compatible vacuum vessel, lubricant-free
- instrumentation up to 0.6 m x 0.6 m x 1.2 m (width x height x length)  
100 kg weight

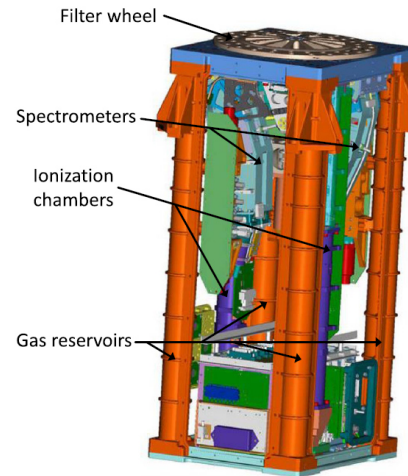


# Examples for full-instrument calibration

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- **SoIACES**
- **PROBA/LYRA II**
- **SPICE**
- **EUI**

# SoIACES with Fraunhofer IPM Freiburg

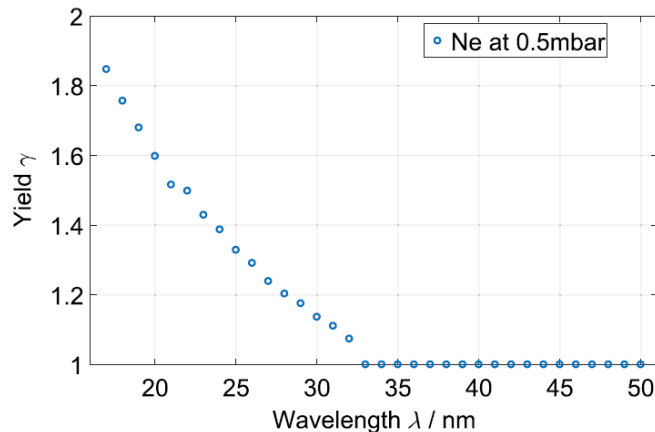


## detector based

According to its auto-calibrating principle, no pre-flight radiometric calibration was requested.

however:

- filter transmission measurement
- AXUV photodiode characterisation
- full instrument test at 17 – 130 nm ( - 240 nm)



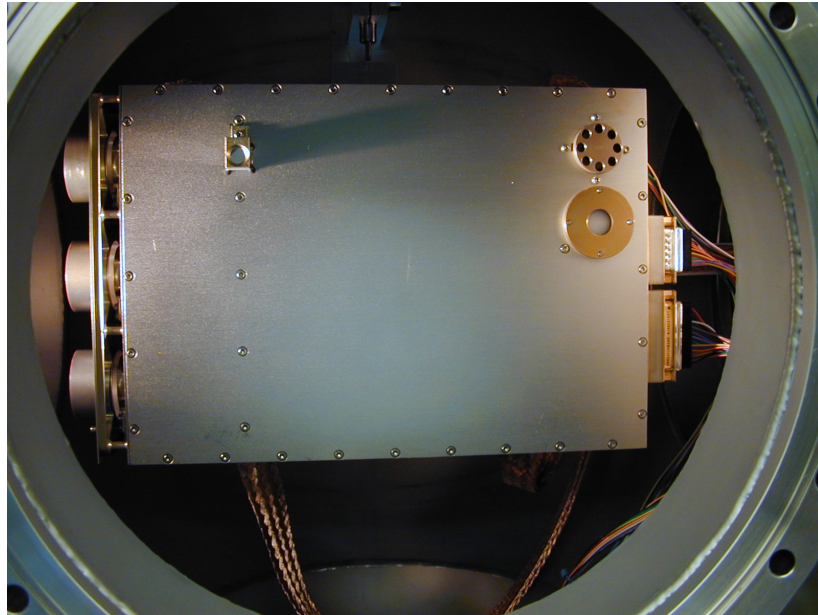
*R. Schäfer et al., Appl. Opt. 57, 6851 (2018)*

## 2015: DIC spare measurements

*(R. Schäfer)*

- higher-order effects (double ionization) in ionisation chamber: yield measurement
- revision of uncertainty budget

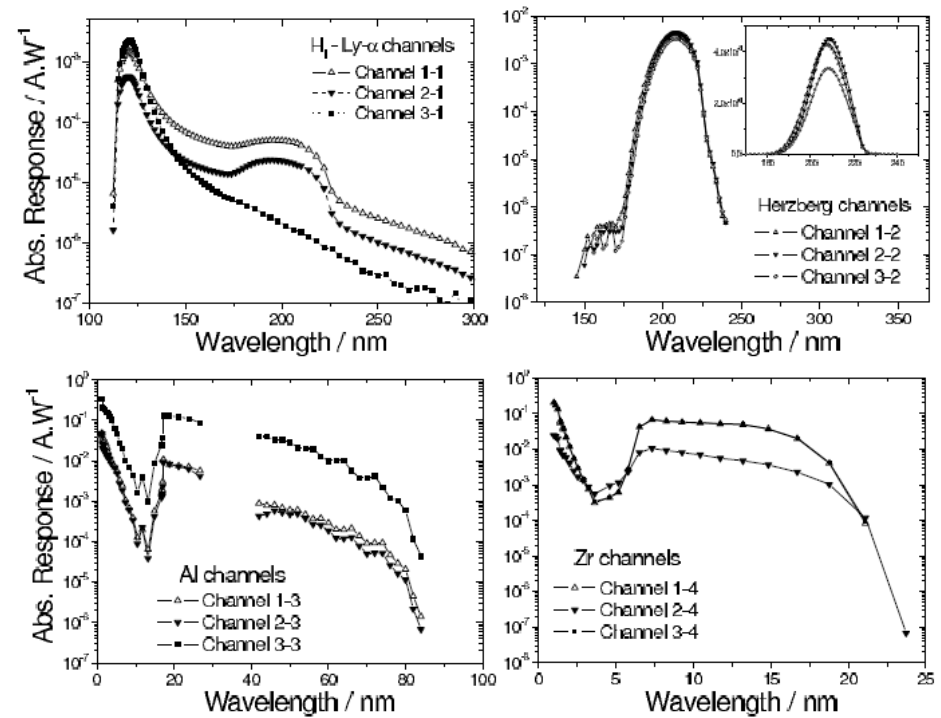
# PROBA2/LYRA with ROB



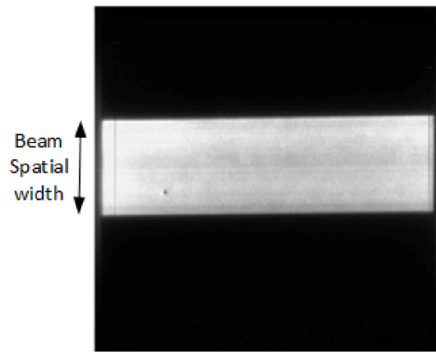
BenMoussa et al., A&A 508, 1085 (2009)

## detector based

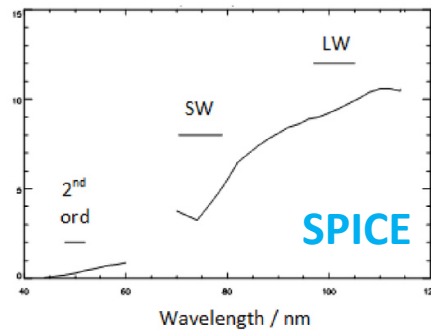
- development/test of detectors
- filter transmission calibration
- pre-flight at-wavelength calibration





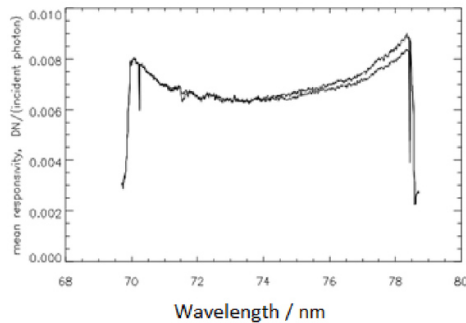


## spectral profiles (calc.)

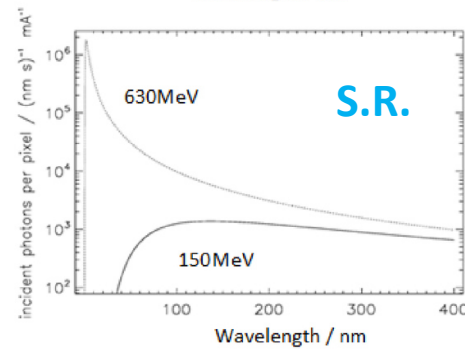


## source based (mainly)

- grating efficiency calibration (ongoing activities on witness grating)
- EM calibration direct against S.R.
- FM calibration by transfer source (HC source at RAL; SOHO-CDS ~1995, EIS ~2006)



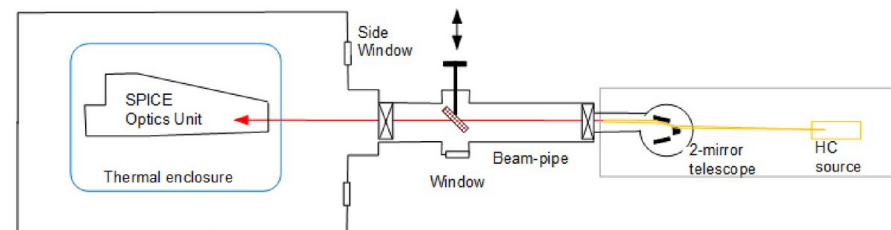
(a)



(b)

■ CDS source recently re-calibrated against S.R., with regard to deviating operation conditions (discharge current)

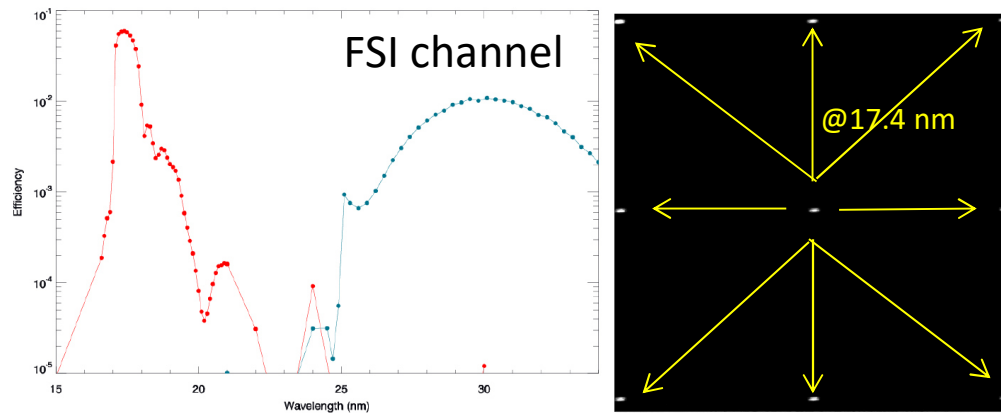
Caldwell et al., SPIE Vol. 10397, 1039708 (2017)





## detector based

- FM at-wavelength calibration  
FSI 17.4 nm, 30.4 nm  
 $\text{HRI}_{\text{EUV}}$ ,  $\text{HRI}_{\text{Ly-}\alpha}$
- FOV characterization



*Halain et al., SPIE 10699H (2018)*

# What PTB can provide

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## Calibration & characterisation of

### optical components:

- filters

spectral transmission

- mirrors

spectral reflectance

- gratings

diffraction efficiency

### detectors:

- photodiodes
- photoemissive/  
photocathodes
- photoconductive
- imagers CCD, APS

spectral responsivity

### spectrometers:

- dispersive type (grating)
- filter radiometer type

spectral responsivity

# Conclusions

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1. Radiometric scales in EUV and VUV are defined with standard uncertainties of **~ 1 %**
2. Radiometric scales can be disseminated /compared with standard uncertainties of **few %** only: limited by availability and stability/reproducibility of transfer standards.  
particularly: spectral range < 150 nm
3. Direct calibration of instruments at S.R. facility:  
source based against storage ring („white“ S.R.) as primary source standard  
detector based using secondary detector standards and monochromatized S.R.  
  
special premise needed (design, optics, size, weight, ...)  
uncertainty typically then limited by the instrument itself
4. Referencing to the absolute radiometric scale:  
monitoring of aging processes (witness samples), ...



**Physikalisch-Technische Bundesanstalt  
Braunschweig und Berlin**

Abbestr. 2-12  
10587 Berlin



Alexander Gottwald  
UV and VUV radiometry working group

Telefon: +49 30 3481 7130



E-Mail: [alexander.gottwald@ptb.de](mailto:alexander.gottwald@ptb.de)  
[www.ptb.de](http://www.ptb.de)

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